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**Magnetoelectric and Ferroelectric Properties of BiFeO<sub>3</sub>/Ni film Deposited by Pulsed Laser Deposition** LI YAN, MUJIN ZHUO, Center for Integrated Nanotechnologies, Los Alamos National Laboratory, ZHIGUANG WANG, JIANJUN YAO, JIEFANG LI, DWIGHT VIEHLAND, Dept. of Materials Science and Engineering, Virginia Tech, QUANXI JIA, Center for Integrated Nanotechnologies, Los Alamos National Laboratory — To fabricate a layer by layer (2-2) magnetoelectric (ME) sensor, ferroelectric (FE) BiFeO<sub>3</sub> film was directly deposited on ferromagnetic (FM) nickel foil by pulsed laser deposition (PLD) without oxide or noble metal buffer layer, which significantly lowers the cost of ME and FE devices, and makes it possible to deposit longer ME and FE bendable band by PLD. X-ray diffraction and transmission electron microscopy analysis confirmed that the BiFeO<sub>3</sub> film was successfully deposited on the top of nickel foil. The BiFeO<sub>3</sub> film had a saturation polarization and a piezoelectric d<sub>33</sub> coefficient of 69  $\mu\text{C}/\text{cm}^2$  and 52 pm/V respectively. The ME coefficient of the sample was 4mV/cmOe which was measured under 1 Oe AC magnetic field at 1 kHz frequency.

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